OptiMOS™-5 Power Transistor

AEC Qualified RoHS

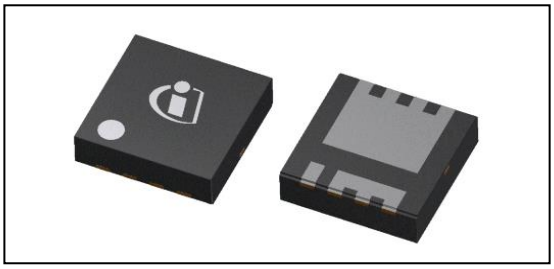
Features

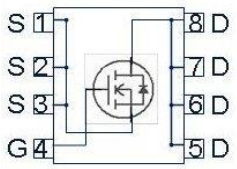
- OptiMOS™ power MOSFET for automotive applications
- N-channel - Enhancement mode - Logic level
- MSL1 up to 260°C peak reflow
- 175 °C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

Product Summary

V_{DS}	60	V
$R_{DS(on),max}$	14	mΩ
I_D	30	A

PG-TSDSON-8-32





Type	Package	Marking
IAUZ30N06S5L140	PG-TSDSON-8-32	5N6L140

Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Drain current	I_D	V_{GS}=10 V, Chip limitation[1,2)]	30	A
		V_{GS}=10V, DC current	30	
		T_a=85 °C, V_{GS}=10 V, R_{thJA} on 2s2p[2,3)]	8	
Pulsed drain current[2)]	$I_{D,pulse}$	T_C=25 °C, t_p= 100 µs	85	
Avalanche energy, single pulse[2)]	E_{AS}	I_D=15 A	27	mJ
Avalanche current, single pulse	I_{AS}	-	30	A
Gate source voltage	V_{GS}	-	±16	V
Power dissipation	P_{tot}	T_C=25 °C	33	W
Operating and storage temperature	T_j, T_{stg}	-	-55 ... +175	°C

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics[2]						
Thermal resistance, junction - case	R_{thJC}	-	-	-	4.6	K/W
Thermal resistance, junction - ambient[3]	R_{thJA}	-	-	37.2	-	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0V, I_D=1mA	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=10µA	1.2	1.7	2.2	
Zero gate voltage drain current	I_{DSS}	V_{DS}=60V, V_{GS}=0V, T_j=25°C	-	-	1	µA
		V_{DS}=60V, V_{GS}=0V, T_j=125°C[1]	-	-	100	
Gate-source leakage current	I_{GSS}	V_{GS}=16V, V_{DS}=0V	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=4.5V, I_D=15A	-	16.3	19.6	mΩ
		V_{GS}=10V, I_D=15A	-	11.2	14	
Gate resistance[2]	R_G	-	-	1.4	-	Ω

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics[2]						
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=30V, f=1MHz	-	683	888	pF
Output capacitance	C_{oss}		-	136	177	
Reverse transfer capacitance	C_{rss}		-	10	15	
Turn-on delay time	$t_{d(on)}$	V_{DD}=30V, V_{GS}=10V, I_D=15A, $R_{G,ext}$=3.5Ω	-	1.6	-	ns
Turn-off delay time	$t_{d(off)}$		-	4.1	-	
Rise time	t_r		-	1.0	-	
Fall time	t_f		-	1.8	-	
Gate Charge Characteristics[2]						
Gate to source charge	Q_{gs}	V_{DD}=30V, I_D=15A, V_{GS}=0 to 10V	-	2.3	2.9	nC
Gate to drain charge	Q_{gd}		-	1.6	2.4	
Gate charge total	Q_g		-	9.4	12.2	
Gate plateau voltage	$V_{plateau}$		-	3.3	-	V
Reverse Diode						
Diode continous forward current[2]	I_S	T_C=25°C	-	-	30	A
Diode pulse current[2]	$I_{S,pulse}$	T_C=25 °C, t_p= 100 µs	-	-	85	
Diode forward voltage	V_{SD}	V_{GS}=0V, I_F=15A, T_j=25°C	-	0.8	1.1	V
Reverse recovery time[2]	t_{rr}	V_R=30V, I_F=30A, di_F/dt=100A/µs	-	26	-	ns
Reverse recovery charge[2]	Q_{rr}		-	18	-	nC

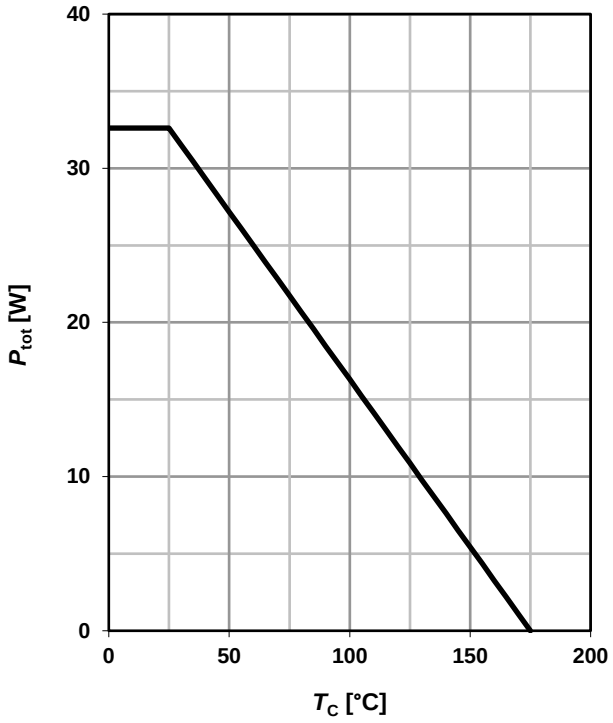
[1] Practically the current is limited by the overall system design including the customer-specific PCB.

[2] The parameter is not subject to production test - verified by design/characterization.

[3] Device on a four-layer 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5-7). PCB is vertical in still air.

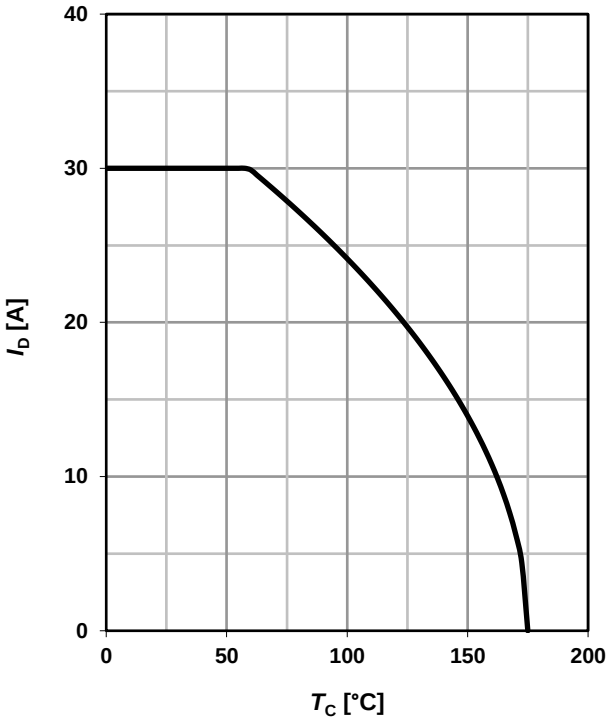
1 Power dissipation

$P_{tot} = f(T_C)$; $V_{GS} = 10$ V



2 Drain current

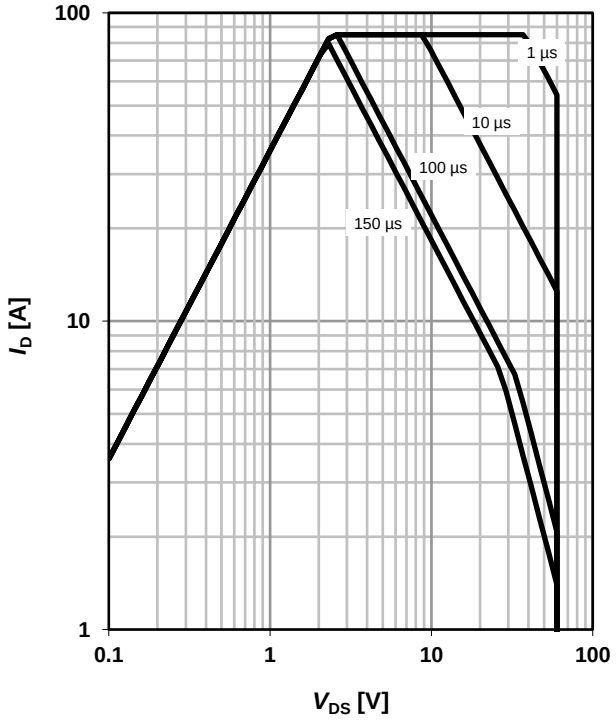
$I_D = f(T_C)$; $V_{GS} = 10$ V



3 Safe operating area

$I_D = f(V_{DS})$; $T_C = 25$ °C; $D = 0$

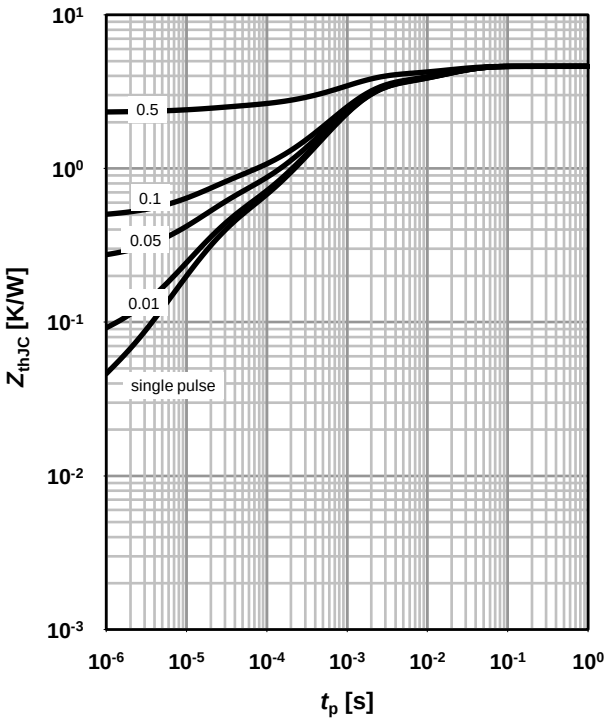
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC} = f(t_p)$

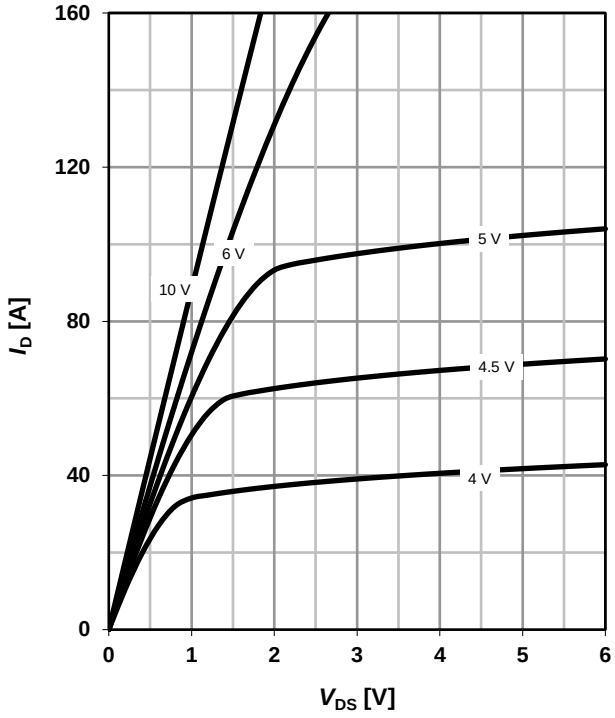
parameter: $D = t_p/T$



5 Typ. output characteristics

$I_D = f(V_{DS})$; $T_j = 25$ °C

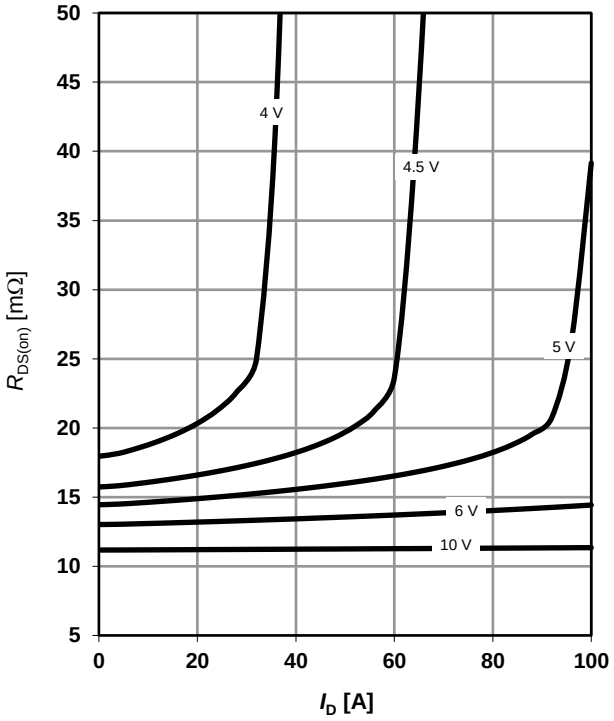
parameter: V_{GS}



6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D)$; $T_j = 25$ °C

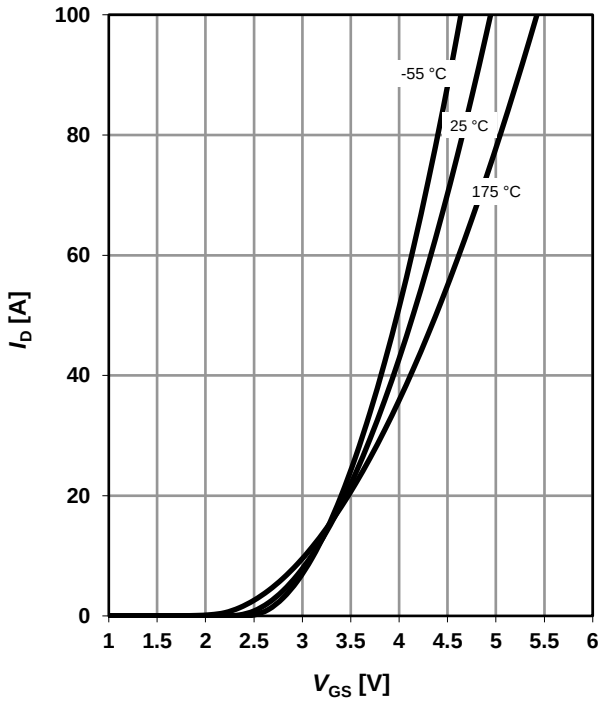
parameter: V_{GS}



7 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} = 6$V

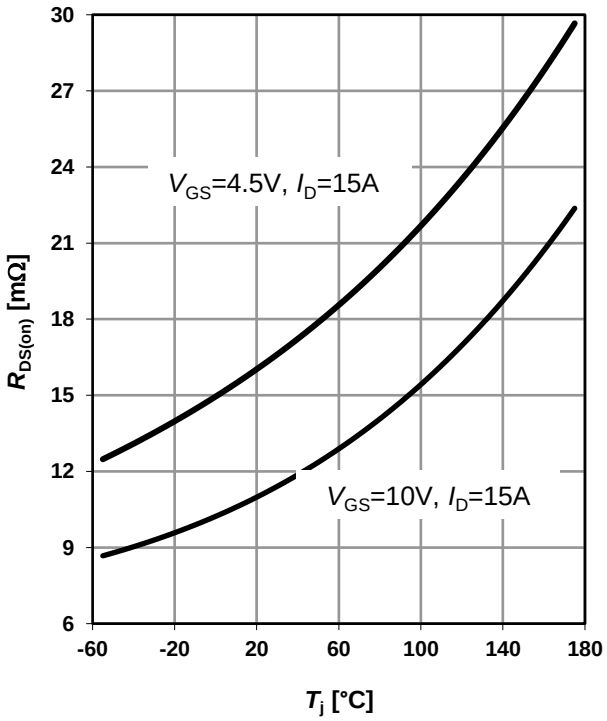
parameter: T_j



8 Typ. drain-source on-state resistance

$R_{DS(on)} = f(T_j)$;

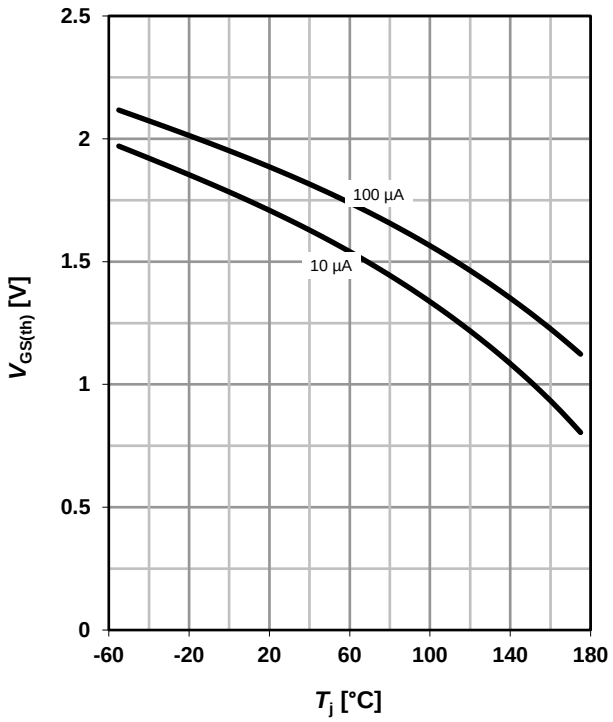
parameter: I_D, V_{GS}



9 Typ. gate threshold voltage

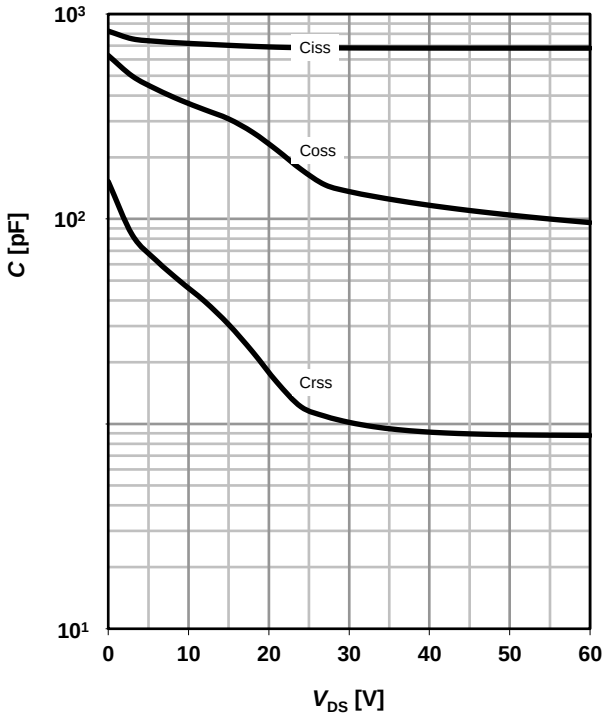
$V_{GS(th)} = f(T_j)$; $V_{GS} = V_{DS}$

parameter: I_D



10 Typ. capacitances

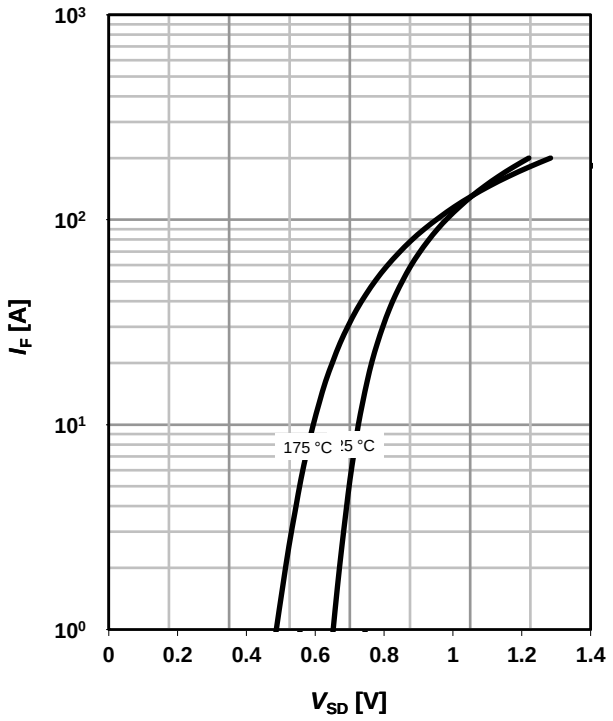
$C = f(V_{DS})$; $V_{GS} = 0$ V; $f = 1$ MHz



11 Typical forward diode characteristics

$I_F = f(V_{SD})$

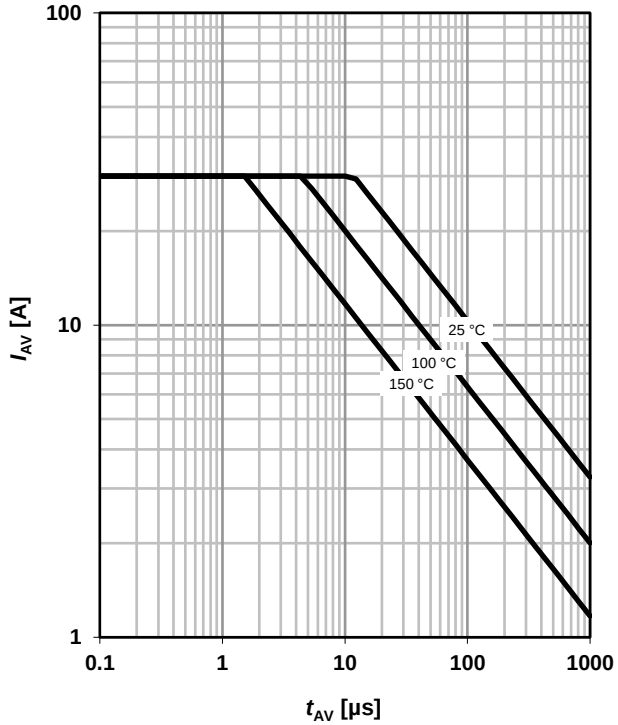
parameter: T_j



12 Avalanche characteristics

$I_{AS} = f(t_{AV})$

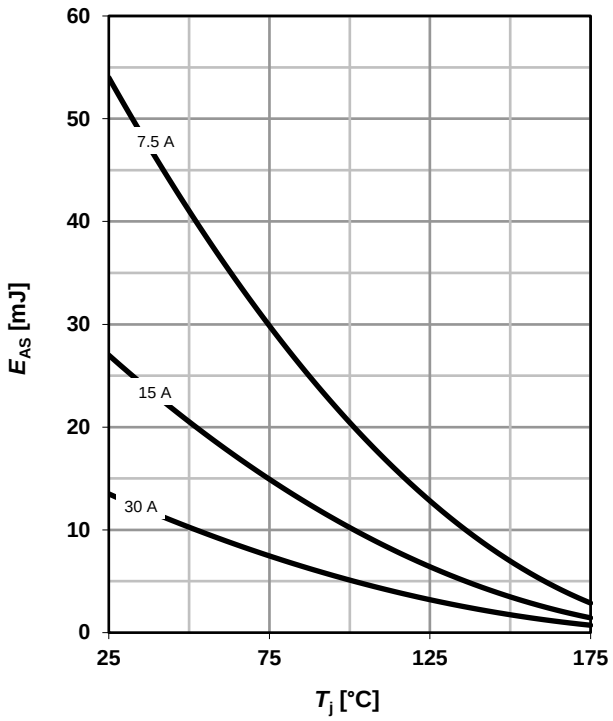
parameter: $T_{j(start)}$



13 Avalanche energy

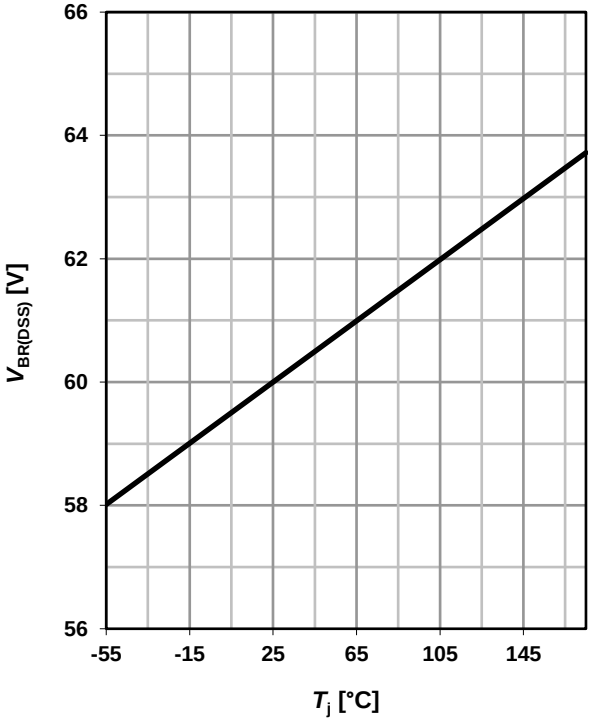
$E_{AS} = f(T_j)$

parameter: I_D



14 Drain-source breakdown voltage

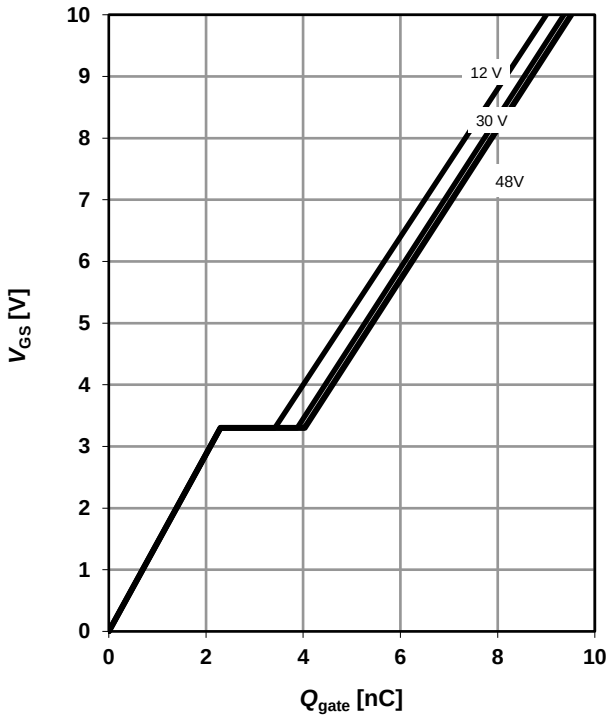
$V_{BR(DSS)} = f(T_j)$; $I_D = 1$ mA



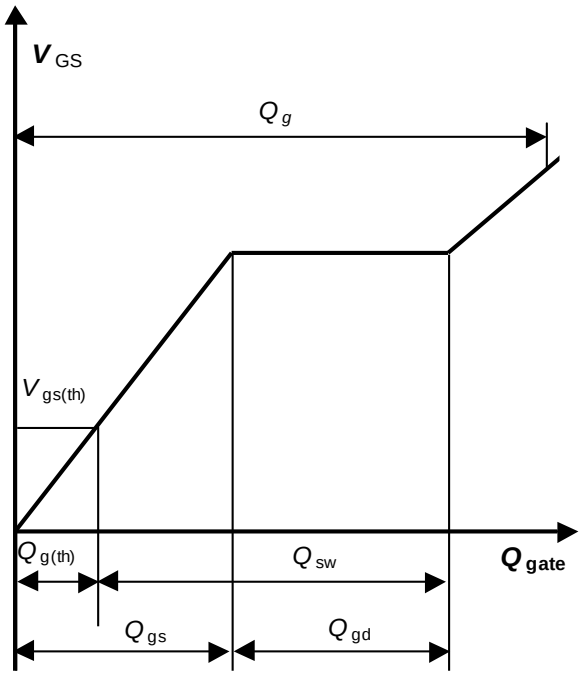
15 Typ. gate charge

$V_{GS} = f(Q_{gate})$; $I_D = 15$ A pulsed

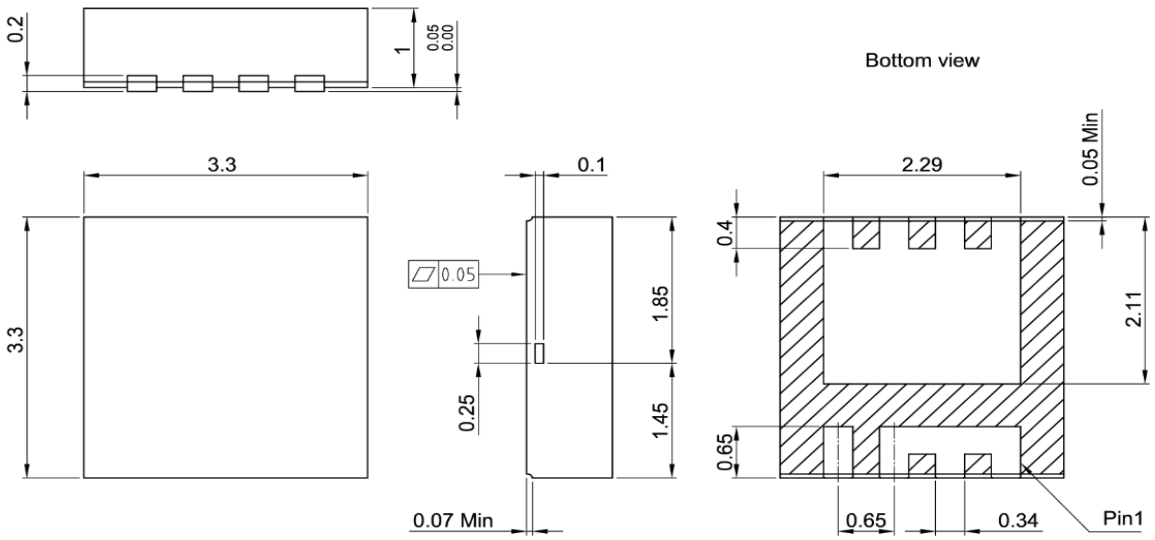
parameter: V_{DD}



16 Gate charge waveforms

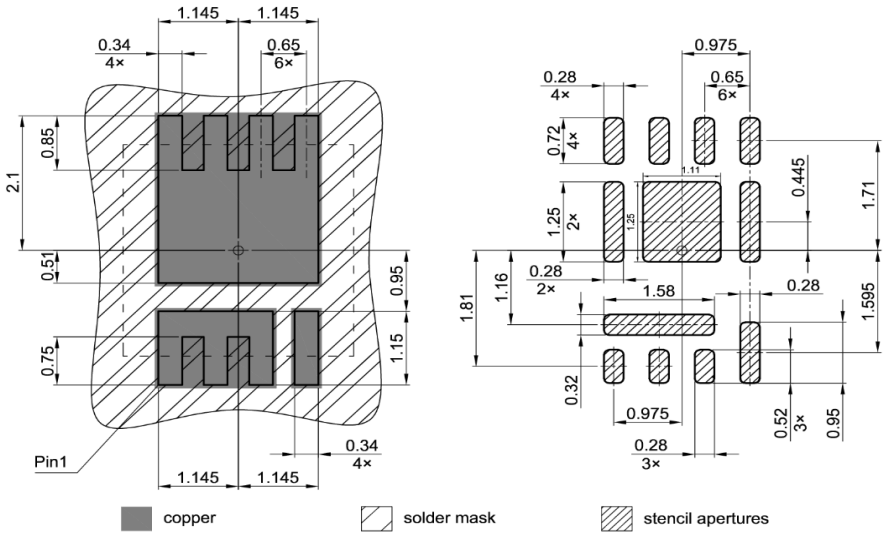


Package Outline



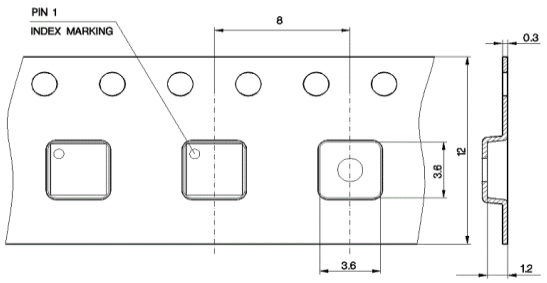
All dimensions are in units mm
The drawing is in compliance with ISO 128-30, Projection Method 1 [⊕]

Footprint



All undimensioned radii is 0.075
Based on stencil thickness 0.13 mm
All dimensions are in units mm

Packaging



Published by
Infineon Technologies AG
81726 Munich, Germany

Legal Disclaimer
The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information
For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings
Due to technical requirements, components may contain dangerous substances.
For information on the types in question, please contact the nearest Infineon Technologies Office.
Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life.
If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

Revision History

Version	Date	Changes
Revision 1.0	07.05.2020	Final Data Sheet
Revision 1.1	18.03.2021	Modified package outline and footprint

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon:
IAUZ30N06S5L140ATMA1